Notice of References Cited Application/Control No. 10/599,832 Examiner PHI HOANG Applicant(s)/Patent Under Reexamination TANAKA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,075,899 A	06-2000	Yoshioka et al.	382/233
*	В	US-2003/0113026 A1	06-2003	Srinivasan et al.	382/239
*	С	US-6,745,320 B1	06-2004	Mitsuishi, Naoki	712/225
*	D	US-6,807,311 B1	10-2004	Callway et al.	382/250
*	Е	US-6,212,231 B1	04-2001	Takano, Hideto	375/240.24
*	F	US-2004/0258399 A1	12-2004	Ishii et al.	386/112
*	G	US-2005/0013368 A1	01-2005	Gallant et al.	375/240.16
*	Н	US-6,750,909 B1	06-2004	Tsai, Mandy Mei-Feng	348/231.2
*	I	US-5,850,483 A	12-1998	Takabatake et al.	382/233
*	J	US-2003/0151609 A1	08-2003	Champion, Mark	345/571
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.